

**CORRECTED INFORMATION
DISCLOSURE STATEMENT BY
APPLICANT**

(Substitute for form 1449/PTO)

ATTY. DOCKET NO.
071971-0724

SERIAL NO.
10/591,597

APPLICANT
Tohru YAMAOKA, et al.

FILING DATE
**September 05,
2006**

GROUP
2614

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind-Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	US	4,441,058	04-03-1984	TANAKA et al.	<u>Corresponds to JP 57-14296</u>
	US	2002/0081846 A1	06-27-2002	HARUHANA et al.	<u>Corresponds to JP 2002-198370</u>
	US	2003/0026443 A1	02-06-2003	YASUNO et al.	<u>Corresponds to JP 2003-047095</u>
	US	2002/0180047 A1	12-05-2002	HARUHANA et al.	
	US	2003/0015798 A1	01-23-2003	HARUHANA et al.	
	US	2007/0217635 A1	06-20-2007	OGURA et al.	
	US	6,731,766 B2	05-04-2004	YASUNO et al.	
	US	6,859,542 B2	02-22-2005	JOHANNSEN et al.	
	US	6,479,878 B1	11-12-2002	OKAWA et al.	<u>Corresponds to JP 11-331988</u>
	US	6,847,090 B2	01-25-2006	LOEPPERT	
	US	5,490,220	02-06-1996	LOEPPERT	
	US	2003/0007655 A1	01-09-2003	YUN et al.	<u>Corresponds to JP 2004-510373</u>
	US	5,677,965	10-14-1997	MORET et al.	<u>Corresponds to JP 06-217397</u>
	US	6,586,163 B1	07-01-2003	OKABE et al.	<u>Corresponds to JP 2001-51424</u>
	US	6,383,832 B1	05-07-2002	NAKABAYASHI	<u>Corresponds to JP 2002-315097</u>
	US	2001/0033670 A1	10-25-2001	TAI et al.	
	US	2004/0114775 A1	06-17-2004	CHANG	
	US	2004/0259286 A1	12-23-2004	DEHE et al.	
	US	2005/0254673 A1	11-17-2005	HSIEH et al.	
	US	7,039,202 B1	05-02-2006	TAKEUCHI	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code-Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.